# **Power MOSFET**

60 V, 295 mA, Dual N–Channel with ESD Protection, SC–88

## Features

- Low R<sub>DS(on)</sub>
- Low Gate Threshold
- Low Input Capacitance
- ESD Protected Gate
- NV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC–Q101 Qualified and PPAP Capable
- This is a Pb–Free Device

## Applications

- Low Side Load Switch
- DC–DC Converters (Buck and Boost Circuits)

## **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise stated)

Parame	Symbol	Value	Unit			
Drain-to-Source Voltage	V <sub>DSS</sub>	60	V			
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V	
Continuous Drain	Steady	$T_A = 25^{\circ}C$	Ι <sub>D</sub>	295	mA	
Current (Note 1)	State	$T_A = 85^{\circ}C$		212		
	t ≤ 5 s	$T_A = 25^{\circ}C$		304		
		$T_A = 85^{\circ}C$		219		
Power Dissipation (Note 1)			P <sub>D</sub>	250	mW	
	t ≤ 5 s			266		
Pulsed Drain Current $t_p = 10 \ \mu s$			I <sub>DM</sub>	900	mA	
Operating Junction and S	T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C			
Source Current (Body Die	ا <sub>S</sub>	210	mA			
Lead Temperature for So (1/8" from case for 10 s)	ΤL	260	°C			
Gate-Source ESD Rating (HBM)			ESD <sub>HBM</sub>	2000	V	
Gate-Source ESD Rating	ESD <sub>MM</sub>	200	V			

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State	$R_{\thetaJA}$	467	°C/W
Junction-to-Ambient - t $\leq$ 5 s	$R_{\thetaJA}$	412	
Junction-to-Lead - Steady State	$R_{ ext{ heta}JL}$	252	

1. Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).



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V <sub>(BR)DSS</sub>	V <sub>(BR)DSS</sub> R <sub>DS(on)</sub> MAX		
60 V	1.6 Ω @ 10 V	295 mA	
	2.5 Ω @ 4.5 V	295 MA	



Top View



## ORDERING INFORMATION

See detailed ordering and shipping information ion page 5 of this data sheet.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise stated)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 V, I_{D} = 250 \mu A$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	$I_D = 250 \ \mu A$ , ref to $25^{\circ}C$			92		mV/°C
Zero Gate Voltage Drain Current	$I_{DSS}$ $V_{GS} = 0 V,$	$T_J = 25^{\circ}C$			1.0	μΑ	
		$V_{\rm DS} = 60 \text{ V}$	T <sub>J</sub> = 125°C			500	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{C}$	<sub>iS</sub> = ±20 V			±10	μΑ
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{DS}$	e = 250 μA	1.0	1.7	2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 500 mA			1.0	1.6	Ω
		V <sub>GS</sub> = 4.5 V, I <sub>E</sub>	4.5 V, I <sub>D</sub> = 200 mA		1.2	2.5	
Forward Transconductance	9fs	$V_{DS} = 5 \text{ V}, \text{ I}_D$	= 200 mA		80		S
Gate Resistance	R <sub>G</sub>				536		Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				26		pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 20 V			4.4		
Reverse Transfer Capacitance	C <sub>RSS</sub>	- 53 -			2.5		
Total Gate Charge	Q <sub>G(TOT)</sub>				0.9		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V	ns = 25 V,		0.2		
Gate-to-Source Charge	Q <sub>GS</sub>	$I_{\rm D} = 200$	mA		0.3		
Gate-to-Drain Charge	Q <sub>GD</sub>				0.28		
SWITCHING CHARACTERISTICS (No	ote 3)						
Turn–On Delay Time	t <sub>d(on)</sub>				22		ns
Rise Time	t <sub>r</sub>	$V_{GS}$ = 4.5 V, $V_{DD}$ = 25 V, I <sub>D</sub> = 200 mA, R <sub>G</sub> = 25 $\Omega$			34		
Turn-Off Delay Time	t <sub>d(off)</sub>				34		1
Fall Time	t <sub>f</sub>				32		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$		0.8	1.2	V
	I <sub>S</sub> = 200 mA		T <sub>J</sub> = 85°C		0.7		1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 2. Pulse Test: pulse width  $\leq$  300 µs, duty cycle  $\leq$  2%. 3. Switching characteristics are independent of operating junction temperatures.

### **TYPICAL PERFORMANCE CURVES**

(T<sub>J</sub> = 25°C unless otherwise noted)



### **TYPICAL PERFORMANCE CURVES**

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ 



0.01

PULSE TIME t,(s) Figure 11. Thermal Response

0.0001

0.001

SINGLE PULSE

0.00001

0.000001

1

10

100

1000

╫

0.1

### Table 1. ORDERING INFORMATION

Part Number	Marking (XX)	Package	Shipping <sup>†</sup>
NTJD5121NT1G	TF	SC-88 (Pb-Free)	3000 / Tape & Reel
NTJD5121NT2G	TF	SC–88 (Pb–Free)	3000 / Tape & Reel
NVJD5121NT1G	VTF	SC–88 (Pb–Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS



- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS. DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH. PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRU-SIONS, OR GATE BURRS SHALL NOT EXCEED 0.20 PER END. DIMENSIONS D AND E1 AT THE OUTERMOST EXTREMES OF
- THE PLASTIC BODY AND DATUM H. DATUMS A AND B ARE DETERMINED AT DATUM H. DIMENSIONS & AND B ARE DETERMINED AT DATUM H. DIMENSIONS & AND C APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.08 AND 0.15 FROM THE TIP.
- DIMENSION b DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 TOTAL IN EXCESS OF DIMENSION 5 AT MAXIMUM MATERIAL CONDI-TION. THE DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OF THE FOOT.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α			1.10			0.043
A1	0.00		0.10	0.000		0.004
A2	0.70	0.90	1.00	0.027	0.035	0.039
b	0.15	0.20	0.25	0.006	0.008	0.010
С	0.08	0.15	0.22	0.003	0.006	0.009
D	1.80	2.00	2.20	0.070	0.078	0.086
Е	2.00	2.10	2.20	0.078	0.082	0.086
E1	1.15	1.25	1.35	0.045	0.049	0.053
е	0.65 BSC			0.026 BSC		
Г	0.26	0.36	0.46	0.010	0.014	0.018
L2	0.15 BSC			0.006 BSC		
aaa	0.15			0.006		
bbb	0.30			0.012		
CCC	0.10			0.004		
ddd	0.10				0.004	

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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